UJA1162

Self-supplied high-speed CAN transceiver with Sleep mode

Rev. 1 — 26 September 2013

Product data sheet

1. General description

The UJA1162 is a 'self-supplied' high-speed CAN transceiver integrating an ISO 11898-2/5 compliant HS-CAN transceiver and an internal 5 V CAN supply. The only supply input is a battery connection. The UJA1162 can be operated in a very low-current Sleep mode with local and bus wake-up capability.

2. Features and benefits

2.1 General

- Self-supplied high-speed CAN transceiver
- ISO 11898-2 and ISO 11898-5 compliant
- Autonomous bus biasing according to ISO 11898-6
- Fully integrated 5 V supply (V_{BUF}) for the CAN transmitter/receiver
- VIO input allows for direct interfacing with 3.3 V to 5 V microcontrollers
- Bus connections are truly floating when power to pin BAT is off

2.2 Designed for automotive applications

- ±8 kV ElectroStatic Discharge (ESD) protection, according to the Human Body Model (HBM) on the CAN bus pins
- ±6 kV ESD protection, according to IEC 61000-4-2 on the CAN bus pins and on pins BAT and WAKE
- CAN bus pins short-circuit proof to ±58 V
- Battery and CAN bus pins are protected against automotive transients according to ISO 7637-3
- Very low quiescent current in Sleep mode
- Leadless HVSON14 package (3 mm × 4.5 mm) with improved Automated Optical Inspection (AOI) capability
- Dark green product (halogen free and Restriction of Hazardous Substances (RoHS) compliant)

2.3 Integrated supply voltage for the CAN transceiver (V_{BUF})

- 5 V nominal output; ±2 % accuracy
- Undervoltage detection at 90 % of nominal value
- Excellent response with a 4.7 μF ceramic output load capacitor
- Turned off in Sleep mode



Self-supplied high-speed CAN transceiver with Sleep mode

2.4 Power Management

- Sleep mode featuring very low supply current
- Remote wake-up capability via standard CAN wake-up pattern
- Local wake-up capability via the WAKE pin
- Entire node can be powered down via the inhibit output, INH

2.5 System control and diagnostic features

- Mode control via SLPN pin
- Overtemperature shutdown
- Transmit data (TXD) dominant time-out function

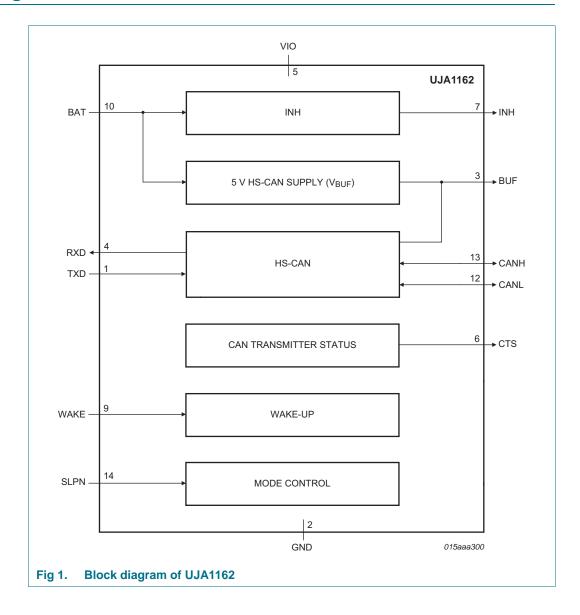
3. Ordering information

Table 1. Ordering information

Type number	Package					
	Name	Description	Version			
UJA1162TK	HVSON14	plastic thermal enhanced very thin small outline package; no leads; 14 terminals; body 3 \times 4.5 \times 0.85 mm	SOT1086-2			

Self-supplied high-speed CAN transceiver with Sleep mode

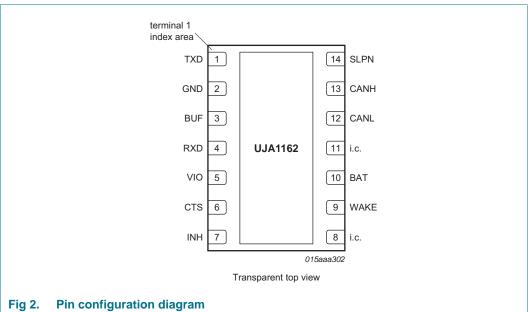
4. Block diagram



Self-supplied high-speed CAN transceiver with Sleep mode

5. Pinning information

5.1 Pinning



5.2 Pin description

Table 2. Pin description

Symbol	Pin	Description
TXD	1	transmit data input
GND	2[1]	ground
BUF	3	5 V transceiver supply voltage
RXD	4	receive data output; reads out data from the bus lines
VIO	5	supply voltage for I/O level adaptor
CTS	6	CAN transmitter status
INH	7	inhibit output for switching external voltage regulators
i.c.	8	internally connected; should be left floating or connected to GND
WAKE	9	local wake-up input
BAT	10	battery supply voltage
i.c.	11	internally connected; should be left floating or connected to GND
CANL	12	LOW-level CAN bus line
CANH	13	HIGH-level CAN bus line
SLPN	14	Sleep mode control input (active LOW)
-		

^[1] HVSON14 package die supply ground is connected to both the GND pin and the exposed center pad. The GND pin must be soldered to board ground. For enhanced thermal and electrical performance, it is recommended to also solder the exposed center pad to board ground.

Self-supplied high-speed CAN transceiver with Sleep mode

6. Functional description

The UJA1162 is a self-supplied high-speed CAN transceiver incorporating a 5 V CAN supply. A variety of fail-safe and diagnostic features offer enhanced system reliability and advanced power management.

6.1 System controller

The system controller is a state machine that manages register configuration and controls the internal functions of the UJA1162. UJA1162 operating modes and state transitions are illustrated in Figure 3. These modes are discussed in more detail in the following sections.

6.1.1 Operating modes

The UJA1162 supports five operating modes: Normal, Standby, Sleep, Overtemp and Off.

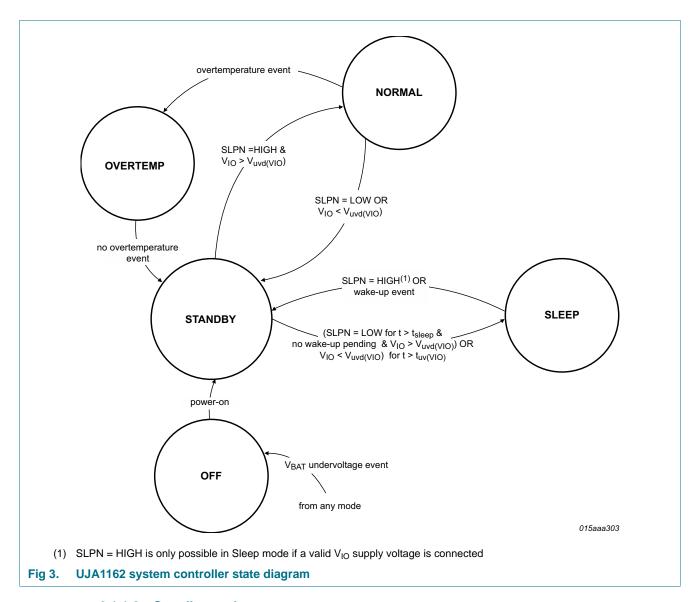
6.1.1.1 Normal mode

Normal mode is the active operating mode. In this mode, the UJA1162 is fully operational. Normal mode can be selected from Standby and Sleep (via Standby) modes by setting pin SLPN HIGH, provided $V_{\text{IO}} > V_{\text{uvd}(\text{VIO})}$. The UJA1162 exits Normal mode:

- if the microcontroller selects Standby mode by setting pin SLPN LOW
- if the UJA1162 detects an undervoltage on VIO, causing the UJA1162 to switch to Standby mode
- if the chip temperature rises above T_{th(act)otp}, causing the UJA1162 to switch to Overtemp mode
- if the battery supply voltage drops below V_{th(det)poff}, causing the UJA1162 to switch to Off mode

All pending wake-up events (power-on, CAN bus wake-up, local wake-up via the WAKE pin) are cleared when the UJA1162 enters Normal mode.

Self-supplied high-speed CAN transceiver with Sleep mode



6.1.1.2 Standby mode

Standby mode is a transitional mode between Normal and Sleep modes. The transceiver is unable to transmit or receive data in Standby mode, but pin INH is active.

The receiver monitors bus activity for a wake-up request in Standby mode. The bus pins are biased at GND level (via $R_{i(cm)}$) when the bus is inactive for $t > t_{to(silence)}$ and at approximately 2.5 V when there is activity on the bus (autonomous biasing). Wake-up can be triggered remotely via a standard wake-up pattern on the CAN bus (see Section 6.3.2) or locally via the WAKE pin. Pin RXD is forced LOW when a bus or local wake-up event is detected.

The UJA1162 switches to Standby mode:

- from Normal mode if pin SLPN goes LOW or and undervoltage is detected on VIO
- from Sleep mode in the event of a local or remote wake-up event or if SLPN = HIGH (with a valid voltage on VIO)

UJA1162

Self-supplied high-speed CAN transceiver with Sleep mode

6.1.1.3 Sleep mode

Sleep mode is the UJA1162's power saving mode. In Sleep mode, the transceiver behaves like in Standby Mode with the exception that pin INH is set floating. Voltage regulators controlled by this pin will be switched off, and the current into pin BAT will be reduced to a minimum.

A HIGH level on SLPN (provided a valid voltage is present on VIO), a local wake-up via the WAKE pin or a remote CAN bus wake-up will cause the UJA1162 to wake up from Sleep mode and switch to Standby mode. Pin RXD is forced LOW when a local wake-up via WAKE or a remote bus wake-up is detected.

The UJA1162 can be set to Sleep mode by holding pin SLPN LOW for $t > t_{\rm sleep}$ (provided there are no wake-up events pending). If one or more wake-up events is pending, the UJA1162 will remain in Standby mode. The UJA1162 must be switched to Normal mode to clear pending wake-up events.

The UJA1162 will also be forced to Sleep mode if an undervoltage lasting longer than $t_{d(uvd-slp)}$ is detected on VIO ($V_{IO} < V_{uvd(VIO)}$). In this event, all pending wake-up events will be cleared automatically.

6.1.1.4 Off mode

The UJA1162 switches to Off mode from any mode when $V_{BAT} < V_{th(det)poff}$. Only power-on detection is enabled; all other modules are inactive. The UJA1162 starts to boot up when the battery voltage rises above the power-on detection threshold $V_{th(det)pon}$ (triggering an initialization process) and switches to Standby mode after $t_{startup}$. Pin RXD is driven LOW when the UJA1162 switches from Off mode to Standby mode, to indicate a power-on event has occurred.

In Off mode, the CAN pins disengage from the bus (zero load; high-ohmic).

6.1.1.5 Overtemp mode

Overtemp mode is provided to prevent the UJA1162 being damaged by excessive temperatures. The UJA1162 switches immediately to Overtemp mode from Normal mode when the global chip temperature rises above the overtemperature protection activation threshold, $T_{th(act)otp}$.

In Overtemp mode, the CAN transmitter and receiver are disabled and the CAN pins are in a high-ohmic state. No wake-up event will be detected, but a pending wake-up will still be signalled by a LOW level on pin RXD, which will persist after the overtemperature event has been cleared. V_{BUF} is off in Overtemp mode.

The UJA1162 exits Overtemp mode:

- and switches to Standby mode if the chip temperature falls below the overtemperature protection release threshold, T_{th(rel)otp}
- if the device is forced to switch to Off mode (V_{BAT} < V_{th(det)poff})

Self-supplied high-speed CAN transceiver with Sleep mode

6.1.1.6 Hardware characterization for the UJA1162 operating modes

Table 3. Hardware characterization by functional block

Block	Operating mode	Operating mode					
	Off	Standby	Normal	Overtemp	Sleep		
V_{BUF}	off	on/off[1]	on	off	off		
CAN	floating	Offline	Active	floating	offline		
RXD	V _{IO} level	V _{IO} level/LOW if wake-up detected	CAN bit stream	V _{IO} level/LOW if wake-up detected	V _{IO} level/LOW if wake-up detected		
INH	off	V _{BAT} level	V _{BAT} level	V _{BAT} level	off		

^[1] V_{BUF} is switched on in Standby mode if a CAN wake-up pattern is detected on the bus; if pin SLPN does not go HIGH within t_{to(silence)}, V_{BUF} is switched off again. V_{BUF} is also switched on in Standby mode if SLPN goes HIGH to select Normal mode.

6.1.2 Mode control via pin SLPN

The UJA1162 can be switched between Normal and Standby/Sleep modes via the SLPN control input (see <u>Figure 3</u>). When SLPN goes LOW, the UJA1162 switches to Standby mode. If SLPN remains low for t_{sleep} , the UJA1162 then switches to Sleep mode (if no wake-up is pending). When SLPN goes HIGH, the UJA1162 switches to Normal mode.

6.2 Power supplies

6.2.1 Battery supply voltage (V_{BAT})

The internal circuitry is supplied from the battery via pin BAT. The device needs to be protected against negative supply voltages, e.g. by using an external series diode. If V_{BAT} falls below the power-off detection threshold, $V_{th(det)poff}$, the UJA1162 switches to Off mode, which means that the internal 5 V CAN supply and other internal logic (except for power-on detection) are shut down.

The UJA1162 switches from Off mode to Standby mode $t_{startup}$ after the battery voltage rises above the power-on detection threshold, $V_{th(det)pon}$. A power-on event is indicated by a LOW level on pin RXD. RXD remains LOW from the moment UJA1162 exits Off mode until it switches to Normal mode.

6.2.2 CAN supply voltage (V_{BUF})

 V_{BUF} provides the internal CAN transceiver with a 5 V supply. The output voltage on BUF is monitored. If V_{BUF} falls below the 90 % undervoltage threshold (90 % of the nominal V_{BUF} output voltage), the CAN transceiver switches to (or remains in) Offline mode.

6.3 High-speed CAN transceiver

The integrated high-speed CAN transceiver is designed for bit rates up to 1 Mbit/s, providing differential transmit and receive capability to a CAN protocol controller. The transceiver is ISO 11898-2 and ISO 11898-5 compliant. The CAN transmitter is supplied from V_{BUF} .

The CAN transceiver supports autonomous CAN biasing as defined in ISO 11898-6, which helps to minimize RF emissions. CANH and CANL are always biased to 2.5 V when the UJA1162 is in Normal mode with $V_{BUF} > 90$ % threshold. Autonomous biasing is active when the UJA1162 is in Standby or Sleep mode with the CAN transceiver in CAN Offline mode - to 2.5 V if there is activity on the bus (CAN Offline Bias mode) and to GND if there

Self-supplied high-speed CAN transceiver with Sleep mode

is no activity on the bus for t > $t_{to(silence)}$ (CAN Offline mode). This is useful when the node is disabled due to a malfunction in the microcontroller. The transceiver ensures that the CAN bus is correctly biased to avoid disturbing ongoing communication between other nodes. The autonomous CAN bias voltage is derived directly from V_{BAT} .

6.3.1 CAN operating modes

The integrated CAN transceiver supports three operating modes: Active, Offline and Offline Bias (see <u>Figure 5</u>). The CAN transceiver operating mode depends on the UJA1162 operating mode and the output voltage on pin BUF.

6.3.1.1 CAN Active mode

In CAN Active mode, the transceiver can transmit and receive data via CANH and CANL. The differential receiver converts the analog data on the bus lines into digital data, which is output on pin RXD. The transmitter converts digital data generated by the CAN controller (input on pin TXD) into analog signals suitable for transmission over the CANH and CANL bus lines.

The CAN transceiver is in Active mode when:

- the UJA1162 is in Normal mode (SLPN = 1) AND
- V_{BUF} > V_{uvd(BUF)} AND
- $V_{IO} > V_{uvd(VIO)}$

In CAN Active mode, the CAN bias voltage is derived from V_{BUF} . If V_{BUF} falls below $V_{uvd(BUF)}$, the UJA1162 exits CAN Active mode and enters CAN Offline Bias mode with autonomous CAN voltage biasing via pin BAT.

If pin TXD is LOW when the transceiver switches to CAN Active mode (UJA1162 in Normal mode; V_{BUF} and V_{IO} ok), the transmitter and receiver will remain disabled until TXD goes HIGH. This prevents network traffic being blocked for $t_{to(dom)TXD}$ (i.e. while the TXD dominant time-out timer is running; see Section 6.7.1) every time the transceiver enters Active mode, if the TXD pin is clamped permanently LOW.

6.3.1.2 CAN Offline and Offline Bias modes

In CAN Offline mode, the transceiver monitors the CAN bus for a wake-up event. CANH and CANL are biased to GND.

CAN Offline Bias mode is the same as CAN Offline mode, with the exception that the CAN bus is biased to 2.5 V. This mode is activated automatically when activity is detected on the CAN bus while the transceiver is in CAN Offline mode. The transceiver will return to CAN Offline mode if the CAN bus is silent (no CAN bus edges) for longer than $t_{to(silence)}$.

The CAN transceiver will switch from CAN Active mode to CAN Offline Bias mode if:

- the UJA1162 switches to Standby/Sleep mode while the CAN bus had been inactive for less than t_{to(silence)} OR
- V_{BUF} < V_{uvd(BUF)} OR V_{IO} < V_{uvd(VIO)}

The CAN transceiver will switch directly from CAN Active mode to CAN Offline mode if:

 the UJA1162 switches to Standby/Sleep mode after the CAN bus had been inactive for more than t_{to(silence)}

Self-supplied high-speed CAN transceiver with Sleep mode

The CAN transceiver switches from CAN Offline Bias mode to CAN Offline mode:

- when the UJA1162 is in Standby/Sleep mode AND
- no activity has been detected on the bus for t > t_{to(silence)}

The CAN transceiver switches from CAN Offline mode to CAN Offline Bias mode if:

- a wake-up event is detected on the CAN bus OR
- the UJA1162 switches to Normal mode while $V_{BUF} < V_{uvd(BUF)}$ OR $V_{IO} < V_{uvd(VIO)}$

6.3.1.3 CAN off

The CAN transceiver is switched off completely with the bus lines floating when:

- the UJA1162 switches to Off or Overtemp mode OR
- V_{BAT} falls below the CAN receiver undervoltage detection threshold, V_{uvd(CAN)}

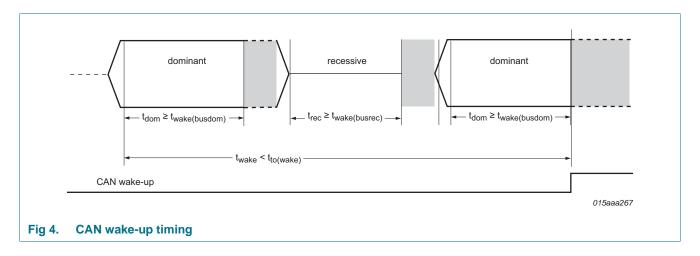
It will be switched on again on entering CAN Offline mode when V_{BAT} rises above the undervoltage release threshold and the UJA1162 is no longer in Off/Overtemp mode.

6.3.2 CAN standard wake-up

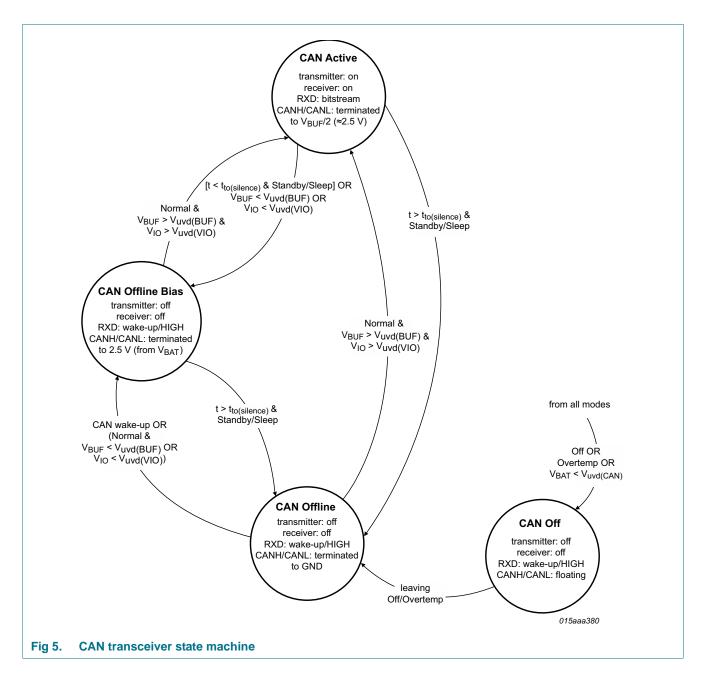
The UJA1162 monitors the bus for a wake-up pattern when the CAN transceiver is in Offline mode.

A filter at the receiver input prevents unwanted wake-up events occurring due to automotive transients or EMI. A dominant-recessive-dominant wake-up pattern must be transmitted on the CAN bus within the wake-up timeout time $(t_{to(wake)})$ to pass the wake-up filter and trigger a wake-up event (see <u>Figure 4</u>; note that additional pulses may occur between the recessive/dominant phases). The recessive and dominant phases must last at least $t_{wake(busrec)}$ and $t_{wake(busdom)}$, respectively.

Pin RXD is driven LOW when a valid CAN wake-up pattern is detected on the bus.



Self-supplied high-speed CAN transceiver with Sleep mode



6.4 WAKE pin

In Standby and Sleep modes, a local wake-up event is triggered by a LOW-to-HIGH or a HIGH-to-LOW transition on the WAKE pin. In applications that don't make use of the local wake-up facility, the WAKE pin should be connected to GND for optimal EMI performance.

6.5 VIO supply pin

Pin VIO should be connected to the microcontroller supply voltage. This will cause the signal levels on TXD, RXD, SLPN and CTS to be adjusted to the I/O levels of the microcontroller, enabling direct interfacing without the need for glue logic.

Self-supplied high-speed CAN transceiver with Sleep mode

6.6 CAN transmit status pin (CTS)

Pin CTS is driven HIGH to indicate to the microcontroller that the transmitter is fully enabled and data can be transmitted via the TXD pin.

Pin CTS is actively driven LOW:

- while the transmitter is starting up (e.g. during a transition from Standby to Normal mode) or
- if pin TXD is clamped LOW for t > t_{to(dom)TXD} or
- · if an undervoltage is detected on VIO or BUF

6.7 CAN fail-safe features

6.7.1 TXD dominant timeout

A TXD dominant time-out timer is started when pin TXD is forced LOW while the transceiver is in CAN Active Mode. If the LOW state on pin TXD persists for longer than the TXD dominant time-out time ($t_{to(dom)TXD}$), the transmitter is disabled, releasing the bus lines to recessive state. This function prevents a hardware and/or software application failure from driving the bus lines to a permanent dominant state (blocking all network traffic). The TXD dominant time-out timer is reset when pin TXD goes HIGH. The TXD dominant time-out time also defines the minimum possible bit rate of 15 kbit/s.

6.7.2 Pull-up on TXD pin

Pin TXD has an internal pull-up (towards V_{IO}) to ensure a safe defined recessive driver state in case the pin is left floating.

6.7.3 Pull-down on SLPN pin

Pin SLPN has an internal pull-down (to GND) to ensure the UJA1162 switches to Sleep mode if SLPN is left floating.

6.7.4 Loss of power at pin BAT

A loss of power at pin BAT has no impact on the bus lines or on the microcontroller. No reverse currents flow from the bus.

Self-supplied high-speed CAN transceiver with Sleep mode

7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Mii	n Max	Unit
V _x	voltage on pin x	DC value			
		pins BUF[1], VIO	-0.	2 +6	V
		pins TXD, RXD, SLPN, CTS	-0.	$V_{IO} + 0.2$	V
		pins WAKE, INH	-18	3 +40	V
		pin BAT	-0.	2 +40	V
		pins CANH and CANL with respect to any other pin	–5 8	3 +58	V
V _(CANH-CANL)	voltage between pin CANH and pin CANL		-40) +40	V
V _{trt}	transient voltage	on pins	[<u>2</u>] -1	50 +100	V
		BAT: via reverse polarity diode and capacitor to ground			
		CANL, CANH, WAKE: coupling via 1 nF capacitors			
V _{ESD}	electrostatic discharge voltage	IEC 61000-4-2	[3]		
		on pins CANH and CANL; pin BAT with capacitor; pin WAKE with 10 nF capacitor and 10 $k\Omega$ resistor	-6	+6	kV
		НВМ	[4]		
		on pins CANH, CANL	<u>[5]</u> –8	+8	kV
		on pins BAT, WAKE	-4	+4	kV
		on any other pin	-2	+2	kV
		MM	[6]		
		on any pin	-10	00 +100	V
		CDM	<u>[7]</u>		
		on corner pins	-75	50 +750	V
		on any other pin	-50	00 +500	V
T_{vj}	virtual junction temperature		<u>[8]</u> –4() +150	°C
T _{stg}	storage temperature		-5	5 +175	°C

^[1] When the device is not powered up, $I_{BUF(max)} = 25 \text{ mA}$.

- [4] Human Body Model (HBM): according to AEC-Q100-002 (100 pF, 1.5 k Ω).
- [5] Pins BUF, VIO and BAT connected to GND, emulating the application circuit.
- [6] Machine Model (MM): according to AEC-Q100-003 (200 pF, 0.75 μ H, 10 Ω).
- [7] Charged Device Model (CDM): according to AEC-Q100-011 (field Induced charge; 4 pF).
- [8] In accordance with IEC 60747-1. An alternative definition of virtual junction temperature is: $T_{vj} = T_{amb} + P \times R_{th(j-a)}$, where $R_{th(j-a)}$ is a fixed value used in the calculation of T_{vj} . The rating for T_{vj} limits the allowable combinations of power dissipation (P) and ambient temperature (T_{amb}).

UJA1162

^[2] Verified by an external test house to ensure pins can withstand ISO 7637 part 2 automotive transient test pulses 1, 2a, 3a and 3b.

^[3] ESD performance according to IEC 61000-4-2 (150 pF, 330 Ω) has been verified by an external test house; the result was equal to or better than ±6 kV.

Self-supplied high-speed CAN transceiver with Sleep mode

8. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Тур	Unit
$R_{th(vj-a)}$	thermal resistance from virtual junction to ambient		<u>[1]</u> 60	K/W

^[1] According to JEDEC JESD51-2, JESD51-5 and JESD51-7 at natural convection on 2s2p board. Board with two inner copper layers (thickness: 35 μm) and thermal via array under the exposed pad connected to the first inner copper layer (thickness: 70 μm).

9. Static characteristics

Table 6. Static characteristics

 $T_{Vj} = -40$ °C to +150 °C; $V_{BAT} = 4.5$ V to 28 V; $V_{IO} = 2.85$ V to 5.5 V; $R_{(CANH-CANL)} = 60$ Ω ; all voltages are defined with respect to ground; positive currents flow into the IC; typical values are given at $V_{BAT} = 13$ V; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Supply; pi	n BAT					
$V_{th(det)pon}$	power-on detection threshold voltage	V _{BAT} rising	4.2	-	4.55	V
$V_{th(det)poff}$	power-off detection threshold voltage	V _{BAT} falling	2.8	-	3	V
$V_{uvr(CAN)}$	CAN undervoltage recovery voltage	V _{BAT} rising	4.5	-	5	V
$V_{uvd(CAN)}$	CAN undervoltage detection voltage	V _{BAT} falling	4.2	-	4.55	V
I _{BAT}	battery supply current	Standby mode; CAN Offline mode; $-40 ^{\circ}\text{C} < T_{vj} < +85 ^{\circ}\text{C};$ $V_{BAT} = 7 ^{\circ}\text{V}$ to 18 V	-	58	81	μА
		Sleep mode; CAN Offline mode; $-40 ^{\circ}\text{C} < T_{vj} < +85 ^{\circ}\text{C};$ $V_{BAT} = 7 ^{\circ}\text{V}$ to 18 V	-	44	62	μА
		additional current in CAN Offline Bias mode; –40 °C < T _{vj} < 85 °C	-	46	63	μА
		Normal mode; CAN Active mode; CAN recessive; V _{TXD} = V _{IO}	-	4	7.5	mA
		Normal mode; CAN Active mode; CAN dominant; V _{TXD} = 0 V	-	46	67	mA
Voltage so	urce; pin BUF					
Vo	output voltage	$V_{BAT} = 5.5 \text{ V to } 18 \text{ V}$	4.9	5	5.1	V
V_{uvd}	undervoltage detection voltage		4.5	-	4.75	V
I _{O(sc)}	short-circuit output current		-300	-	-150	mA
Supply; pi	n VIO					
V_{uvd}	undervoltage detection voltage		2.7	-	2.85	V
$I_{I(VIO)}$	input current on pin VIO	Standby/Normal mode; -40 °C < T _{vj} < 85 °C	-	7.1	11	μА
		Sleep mode; -40 °C < T_{vj} < 85 °C	-	5.9	9.5	μΑ

Self-supplied high-speed CAN transceiver with Sleep mode

 Table 6.
 Static characteristics ...continued

 $T_{Vj} = -40$ °C to +150 °C; $V_{BAT} = 4.5$ V to 28 V; $V_{IO} = 2.85$ V to 5.5 V; $R_{(CANH-CANL)} = 60$ Ω ; all voltages are defined with respect to ground; positive currents flow into the IC; typical values are given at $V_{BAT} = 13$ V; unless otherwise specified.

Symbol	Parameter	Conditions		Min	Тур	Max	Un
Sleep mode	e control input; pin SLPN						
V _{th(sw)}	switching threshold voltage			0.25V _{IO}	-	0.75V _{IO}	V
R _{pd}	pull-down resistance			40	60	80	kΩ
Inhibit outp	ut: pin INH						
Vo	output voltage	I _{INH} = -180 μA		$V_{BAT}-0.8$	-	V_{BAT}	V
R _{pd}	pull-down resistance	Sleep mode		3	4	5	MΩ
CAN transn	nit data input; pin TXD						
V _{th(sw)}	switching threshold voltage			0.25V _{IO}	-	0.75V _{IO}	V
R_{pu}	pull-up resistance			40	60	80	kΩ
	nitter status; pin CTS						
Гон	HIGH-level output current	$V_{CTS} = V_{IO} - 0.4 V;$ transmitter on		-	-	-4	m/
l _{OL}	LOW-level output current	$V_{CTS} = 0.4 \text{ V};$ transmitter off		4	-	-	m/
CAN receive	e data output; pin RXD						
V _{OH}	HIGH-level output voltage	$I_{OH} = -4 \text{ mA}$		$V_{IO}-0.4$	-	-	٧
V _{OL}	LOW-level output voltage	$I_{OL} = 4 \text{ mA}$		-	-	0.4	٧
R _{pu}	pull-up resistance	CAN Offline mode		40	60	80	kΩ
Local wake	input; pin WAKE						
$V_{th(sw)r}$	rising switching threshold voltage			2.8	-	4.1	V
$V_{th(sw)f}$	falling switching threshold voltage			2.4	-	3.75	V
$V_{hys(i)}$	input hysteresis voltage			250	-	800	m\
l _i	input current	$T_{vj} = -40 ^{\circ}\text{C} \text{ to } +85 ^{\circ}\text{C}$		-	-	1.5	μΑ
High-speed	CAN bus lines; pins CANH and	CANL					
$V_{O(dom)}$	dominant output voltage	CAN Active mode; V _{TXD} = 0 V; V _{BAT} > 5.5 V					
		pin CANH		2.75	3.5	4.5	٧
		pin CANL		0.5	1.5	2.25	٧
V_{TXsym}	transmitter voltage symmetry	$V_{TXsym} = V_{CANH} + V_{CANL};$ $f_{TXD} = 250 \text{ kHz}; C_{SPLIT} = 4.7 \text{ nF}$	[1] [2]	0.9V _{BUF}	-	1.1V _{BUF}	V
$V_{dom(TX)sym}$	transmitter dominant voltage symmetry	$V_{dom(TX)sym} = V_{BUF} - V_{CANH} - V_{CANL};$ $V_{BAT} > 5.5 V$		-400	-	+400	m\
$V_{O(dif)bus}$	bus differential output voltage	CAN Active mode (dominant); $V_{TXD} = 0 \text{ V}; V_{BAT} > 5.5 \text{ V}$ $R_{(CANH-CANL)} = 45 \Omega$ to 65Ω ;		1.5	-	3.0	V
		CAN Active mode (recessive); CAN Offline mode; $V_{TXD} = V_{IO}$; $R_{(CANH-CANL)} = no load;$ $V_{BAT} > 5.5 \text{ V}; T_{vj} < 150 ^{\circ}\text{C}$		-50	-	+50	m\

Self-supplied high-speed CAN transceiver with Sleep mode

 Table 6.
 Static characteristics ...continued

 $T_{vj} = -40$ °C to +150 °C; $V_{BAT} = 4.5$ V to 28 V; $V_{IO} = 2.85$ V to 5.5 V; $R_{(CANH-CANL)} = 60$ Ω ; all voltages are defined with respect to ground; positive currents flow into the IC; typical values are given at $V_{BAT} = 13$ V; unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{O(rec)}	recessive output voltage	CAN Active mode; $V_{TXD} = V_{IO}$; $V_{BAT} > 5.5 V$; $R_{(CANH-CANL)} = no load$	2	0.5V _{BUF}	3	V
		CAN Offline mode; $V_{BAT} > 5.5 \text{ V}$; $R_{(CANH-CANL)} = \text{no load}$	-0.1	-	+0.1	V
		CAN Offline Bias mode; R _(CANH-CANL) = no load	2	2.5	3	V
$I_{O(dom)}$	dominant output current	CAN Active mode; V _{BAT} > 5.5 V; V _{TXD} = 0 V				
		pin CANH; V _{CANH} = 0 V	-50	-	-	mΑ
		pin CANL; V _{CANL} = 5 V	-	-	52	mA
I _{O(rec)}	recessive output current	$V_{CANL} = V_{CANH} = -27 \text{ V to}$ +32 V; $V_{TXD} = V_{IO}$	-3	-	+3	mA
$V_{th(RX)dif}$	differential receiver threshold voltage	CAN Active mode; $V_{CANL} = V_{CANH} = -12 \text{ V to}$ +12 V; $V_{BAT} > 5.5 \text{ V}$	0.5	0.7	0.9	V
		CAN Offline mode; $V_{CANL} = V_{CANH} = -12 \text{ V to}$ $+12 \text{ V; } V_{BAT} > 5.5 \text{ V}$	0.4	0.7	1.15	V
$V_{hys(RX)dif}$	differential receiver hysteresis voltage	CAN Active mode; $V_{CANL} = V_{CANH} = -12 \text{ V to}$ +12 V; $V_{BAT} > 5.5 \text{ V}$	50	200	400	mV
R _{i(cm)}	common-mode input resistance		9	15	28	$k\Omega$
ΔR_i	input resistance deviation		-1	-	+1	%
R _{i(dif)}	differential input resistance		19	30	52	kΩ
$C_{i(cm)}$	common-mode input capacitance		[1] -	-	20	pF
$C_{i(dif)}$	differential input capacitance		<u>[1]</u> -	-	10	pF
I _{LI}	input leakage current	$V_{BAT} = V_{BUF} = 0 \text{ V or}$ $V_{BAT} = V_{BUF} = \text{shorted to ground}$ via 47 k Ω ; $V_{CANH} = V_{CANL} = 5 \text{ V}$	-5	-	+5	μА
Temperatu	re protection					
T _{th(act)otp}	overtemperature protection activation threshold temperature		167	177	187	°C
T _{th(rel)otp}	overtemperature protection release threshold temperature		127	137	147	°C

^[1] Not tested in production; guaranteed by design.

^[2] The test circuit used to measure the bus output voltage symmetry (which includes C_{SPLIT}) is shown in Figure 9.

Self-supplied high-speed CAN transceiver with Sleep mode

10. Dynamic characteristics

Table 7. Dynamic characteristics

 T_{vj} = -40 °C to +150 °C; V_{BAT} = 4.5 V to 28 V; V_{IO} = 2.85 V to 5.5 V; $R_{(CANH\text{-}CANL)}$ = 60 Ω ; $C_{(CANH\text{-}CANL)}$ = 100 pF; all voltages are defined with respect to ground; positive currents flow into the IC; typical values are given at V_{BAT} = 13 V; unless otherwise specified.

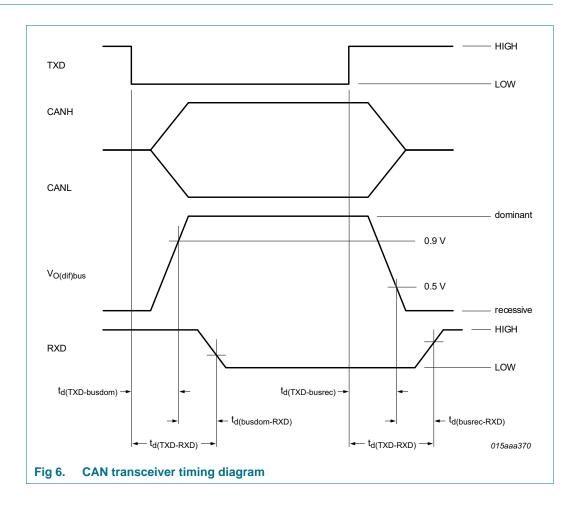
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Voltage source	es; pins BUF and VIO					
t _{startup}	start-up time	from V_{BAT} exceeding the power-on detection threshold until V_{BUF} > 90 % undervoltage threshold	-	2.8	4.7	ms
t _{d(uvd)}	undervoltage detection delay time		6	-	39	μS
t _{d(uvd-sleep)}	delay time from undervoltage detection to sleep mode	from undervoltage detection on VIO until UJA1162 forced to Sleep mode	200	-	400	ms
Mode control	: pin SLPN					
t _{fltr(sleep)}	sleep filter time		2.5	-	13.5	μS
t _{d(sleep)}	sleep delay time	minimum LOW time to trigger a transition to Sleep mode	21	-	36	μS
Pin WAKE						
t _{det(wake)}	wake-up detection time		7	-	42	μS
CAN transcei	ver timing; pins CANH, CANL, TXD ar	nd RXD				
$t_{d(TXD-RXD)}$	delay time from TXD to RXD	50 % V_{TXD} to 50 % V_{RXD} ; $C_{RXD} = 15 \text{ pF}$; $f_{TXD} = 250 \text{ kHz}$	-	-	255	ns
t _{d(TXD-busdom)}	delay time from TXD to bus dominant		-	80	-	ns
t _{d(TXD-busrec)}	delay time from TXD to bus recessive		-	80	-	ns
t _{d(busdom-RXD)}	delay time from bus dominant to RXD	C _{RXD} = 15 pF	-	105	-	ns
t _{d(busrec-RXD)}	delay time from bus recessive to RXD	C _{RXD} = 15 pF	-	120	-	ns
twake(busdom)	bus dominant wake-up time	first pulse (after first recessive) for wake-up on pins CANH and CANL; CAN Offline mode	0.5	-	3.0	μS
		second pulse for wake-up on pins CANH and CANL	0.5	-	3.0	μS
t _{wake(busrec)}	bus recessive wake-up time	first pulse for wake-up on pins CANH and CANL; CAN Offline mode	0.5	-	3.0	μS
		second pulse (after first dominant) for wake-up on pins CANH and CANL	0.5	-	3.0	μS
t _{to(wake)}	wake-up time-out time	between first and second dominant pulses; CAN Offline mode	570	-	1200	μS
$t_{to(dom)TXD}$	TXD dominant time-out time	CAN Active mode; V _{TXD} = 0 V	2.7	-	3.3	ms

Self-supplied high-speed CAN transceiver with Sleep mode

 Table 7.
 Dynamic characteristics ...continued

 T_{Vj} = -40 °C to +150 °C; V_{BAT} = 4.5 V to 28 V; V_{IO} = 2.85 V to 5.5 V; $R_{(CANH-CANL)}$ = 60 Ω ; $C_{(CANH-CANL)}$ = 100 pF; all voltages are defined with respect to ground; positive currents flow into the IC; typical values are given at V_{BAT} = 13 V; unless otherwise specified.

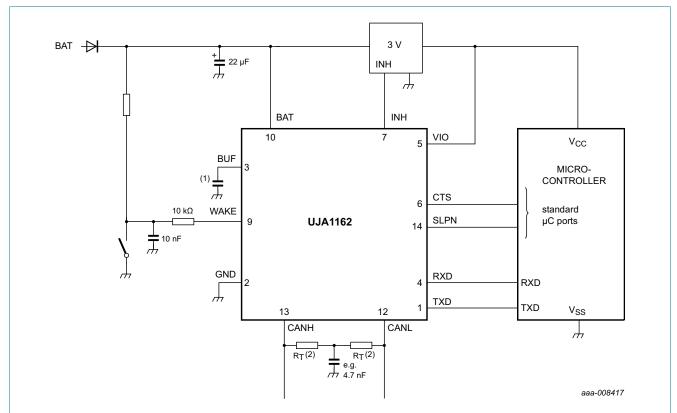
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
t _{to(silence)}	bus silence time-out time	recessive time measurement started in all CAN modes; $R_L = 120 \; \Omega$	0.95	-	1.17	S
t _{d(busact-bias)}	delay time from bus active to bias		-	-	200	μS
t _{startup(CAN)}	CAN start-up time	when switching to Active mode (CTS = 1)	-	-	220	μS



Self-supplied high-speed CAN transceiver with Sleep mode

11. Application information

11.1 Application diagram

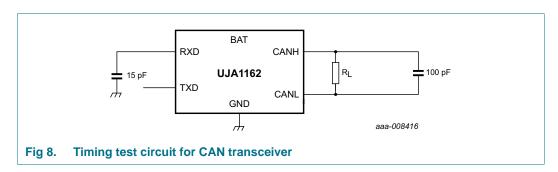


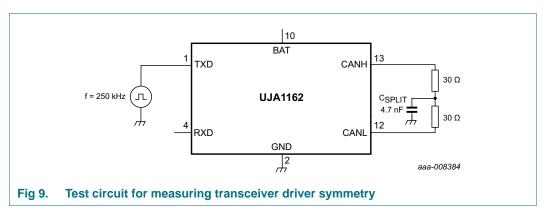
- (1) Actual capacitance value must be a least 1.76 μF with 5 V DC offset (recommended capacitor value is 4.7 μF)
- (2) For bus line end nodes, $R_T = 60~\Omega$ in order to support the 'split termination concept'. For sub-nodes, an optional 'weak' termination of e.g. $R_T = 1.3~k\Omega$ can be used, if required by the OEM.

Fig 7. Typical application using the UJA1162

Self-supplied high-speed CAN transceiver with Sleep mode

12. Test information





12.1 Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard Q100 - Failure mechanism based stress test qualification for integrated circuits, and is suitable for use in automotive applications.

UJA1162 NXP Semiconductors

Self-supplied high-speed CAN transceiver with Sleep mode

13. Package outline

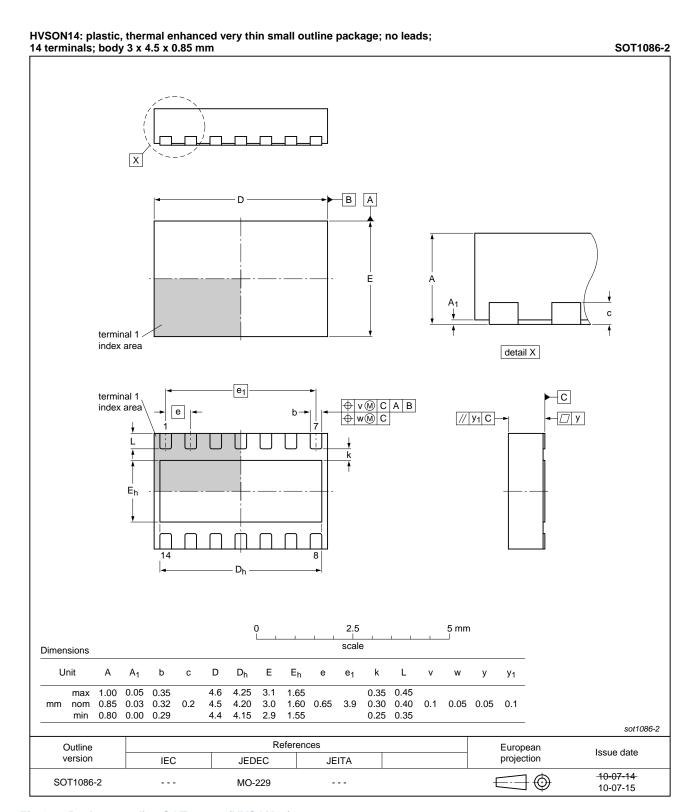


Fig 10. Package outline SOT1086-2 (HVSON14)

All information provided in this document is subject to legal disclaimers.

14. Handling information

All input and output pins are protected against ElectroStatic Discharge (ESD) under normal handling. When handling ensure that the appropriate precautions are taken as described in *JESD625-A* or equivalent standards.

Self-supplied high-speed CAN transceiver with Sleep mode

15. Soldering of SMD packages

This text provides a very brief insight into a complex technology. A more in-depth account of soldering ICs can be found in Application Note *AN10365* "Surface mount reflow soldering description".

15.1 Introduction to soldering

Soldering is one of the most common methods through which packages are attached to Printed Circuit Boards (PCBs), to form electrical circuits. The soldered joint provides both the mechanical and the electrical connection. There is no single soldering method that is ideal for all IC packages. Wave soldering is often preferred when through-hole and Surface Mount Devices (SMDs) are mixed on one printed wiring board; however, it is not suitable for fine pitch SMDs. Reflow soldering is ideal for the small pitches and high densities that come with increased miniaturization.

15.2 Wave and reflow soldering

Wave soldering is a joining technology in which the joints are made by solder coming from a standing wave of liquid solder. The wave soldering process is suitable for the following:

- Through-hole components
- Leaded or leadless SMDs, which are glued to the surface of the printed circuit board

Not all SMDs can be wave soldered. Packages with solder balls, and some leadless packages which have solder lands underneath the body, cannot be wave soldered. Also, leaded SMDs with leads having a pitch smaller than ~0.6 mm cannot be wave soldered, due to an increased probability of bridging.

The reflow soldering process involves applying solder paste to a board, followed by component placement and exposure to a temperature profile. Leaded packages, packages with solder balls, and leadless packages are all reflow solderable.

Key characteristics in both wave and reflow soldering are:

- Board specifications, including the board finish, solder masks and vias
- Package footprints, including solder thieves and orientation
- The moisture sensitivity level of the packages
- Package placement
- Inspection and repair
- Lead-free soldering versus SnPb soldering

15.3 Wave soldering

Key characteristics in wave soldering are:

UJA1162

Self-supplied high-speed CAN transceiver with Sleep mode

- Process issues, such as application of adhesive and flux, clinching of leads, board transport, the solder wave parameters, and the time during which components are exposed to the wave
- Solder bath specifications, including temperature and impurities

15.4 Reflow soldering

Key characteristics in reflow soldering are:

- Lead-free versus SnPb soldering; note that a lead-free reflow process usually leads to higher minimum peak temperatures (see <u>Figure 11</u>) than a SnPb process, thus reducing the process window
- Solder paste printing issues including smearing, release, and adjusting the process window for a mix of large and small components on one board
- Reflow temperature profile; this profile includes preheat, reflow (in which the board is heated to the peak temperature) and cooling down. It is imperative that the peak temperature is high enough for the solder to make reliable solder joints (a solder paste characteristic). In addition, the peak temperature must be low enough that the packages and/or boards are not damaged. The peak temperature of the package depends on package thickness and volume and is classified in accordance with Table 8 and 9

Table 8. SnPb eutectic process (from J-STD-020D)

Package thickness (mm)	Package reflow temperature (°C)			
	Volume (mm³)			
	< 350	≥ 350		
< 2.5	235	220		
≥ 2.5	220	220		

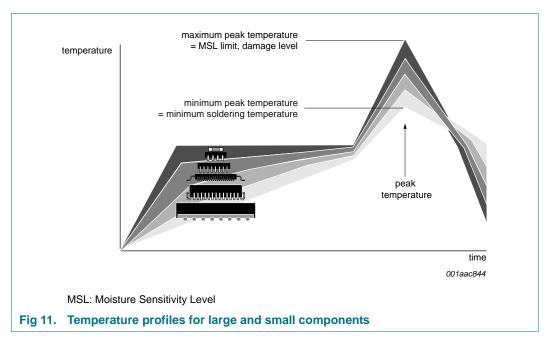
Table 9. Lead-free process (from J-STD-020D)

Package thickness (mm)	Package reflow temperature (°C)				
	Volume (mm³)				
	< 350	350 to 2000	> 2000		
< 1.6	260	260	260		
1.6 to 2.5	260	250	245		
> 2.5	250	245	245		

Moisture sensitivity precautions, as indicated on the packing, must be respected at all times.

Studies have shown that small packages reach higher temperatures during reflow soldering, see Figure 11.

Self-supplied high-speed CAN transceiver with Sleep mode



For further information on temperature profiles, refer to Application Note *AN10365* "Surface mount reflow soldering description".

16. Soldering of HVSON packages

<u>Section 15</u> contains a brief introduction to the techniques most commonly used to solder Surface Mounted Devices (SMD). A more detailed discussion on soldering HVSON leadless package ICs can found in the following application notes:

- AN10365 'Surface mount reflow soldering description"
- AN10366 "HVQFN application information"

Self-supplied high-speed CAN transceiver with Sleep mode

17. Revision history

Table 10. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
UJA1162 v.1	20130926	Product data sheet	-	-

Self-supplied high-speed CAN transceiver with Sleep mode

18. Legal information

18.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

18.2 Definitions

Draft — The document is a draft version only. The content is still under internal review and subject to formal approval, which may result in modifications or additions. NXP Semiconductors does not give any representations or warranties as to the accuracy or completeness of information included herein and shall have no liability for the consequences of use of such information.

Short data sheet — A short data sheet is an extract from a full data sheet with the same product type number(s) and title. A short data sheet is intended for quick reference only and should not be relied upon to contain detailed and full information. For detailed and full information see the relevant full data sheet, which is available on request via the local NXP Semiconductors sales office. In case of any inconsistency or conflict with the short data sheet, the full data sheet shall prevail.

Product specification — The information and data provided in a Product data sheet shall define the specification of the product as agreed between NXP Semiconductors and its customer, unless NXP Semiconductors and customer have explicitly agreed otherwise in writing. In no event however, shall an agreement be valid in which the NXP Semiconductors product is deemed to offer functions and qualities beyond those described in the Product data sheet.

18.3 Disclaimers

Limited warranty and liability — Information in this document is believed to be accurate and reliable. However, NXP Semiconductors does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information. NXP Semiconductors takes no responsibility for the content in this document if provided by an information source outside of NXP Semiconductors.

In no event shall NXP Semiconductors be liable for any indirect, incidental, punitive, special or consequential damages (including - without limitation - lost profits, lost savings, business interruption, costs related to the removal or replacement of any products or rework charges) whether or not such damages are based on tort (including negligence), warranty, breach of contract or any other legal theory.

Notwithstanding any damages that customer might incur for any reason whatsoever, NXP Semiconductors' aggregate and cumulative liability towards customer for the products described herein shall be limited in accordance with the *Terms and conditions of commercial sale* of NXP Semiconductors.

Right to make changes — NXP Semiconductors reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

Suitability for use in automotive applications — This NXP Semiconductors product has been qualified for use in automotive applications. Unless otherwise agreed in writing, the product is not designed, authorized or warranted to be suitable for use in life support, life-critical or safety-critical systems or equipment, nor in applications where failure or malfunction of an NXP Semiconductors product can reasonably be expected to result in personal injury, death or severe property or environmental damage. NXP Semiconductors and its suppliers accept no liability for inclusion and/or use of NXP Semiconductors products in such equipment or applications and therefore such inclusion and/or use is at the customer's own

Applications — Applications that are described herein for any of these products are for illustrative purposes only. NXP Semiconductors makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

Customers are responsible for the design and operation of their applications and products using NXP Semiconductors products, and NXP Semiconductors accepts no liability for any assistance with applications or customer product design. It is customer's sole responsibility to determine whether the NXP Semiconductors product is suitable and fit for the customer's applications and products planned, as well as for the planned application and use of customer's third party customer(s). Customers should provide appropriate design and operating safeguards to minimize the risks associated with their applications and products.

NXP Semiconductors does not accept any liability related to any default, damage, costs or problem which is based on any weakness or default in the customer's applications or products, or the application or use by customer's third party customer(s). Customer is responsible for doing all necessary testing for the customer's applications and products using NXP Semiconductors products in order to avoid a default of the applications and the products or of the application or use by customer's third party customer(s). NXP does not accept any liability in this respect.

Limiting values — Stress above one or more limiting values (as defined in the Absolute Maximum Ratings System of IEC 60134) will cause permanent damage to the device. Limiting values are stress ratings only and (proper) operation of the device at these or any other conditions above those given in the Recommended operating conditions section (if present) or the Characteristics sections of this document is not warranted. Constant or repeated exposure to limiting values will permanently and irreversibly affect the quality and reliability of the device.

Terms and conditions of commercial sale — NXP Semiconductors products are sold subject to the general terms and conditions of commercial sale, as published at http://www.nxp.com/profile/terms, unless otherwise agreed in a valid written individual agreement. In case an individual agreement is concluded only the terms and conditions of the respective agreement shall apply. NXP Semiconductors hereby expressly objects to applying the customer's general terms and conditions with regard to the purchase of NXP Semiconductors products by customer.

Self-supplied high-speed CAN transceiver with Sleep mode

No offer to sell or license — Nothing in this document may be interpreted or construed as an offer to sell products that is open for acceptance or the grant, conveyance or implication of any license under any copyrights, patents or other industrial or intellectual property rights.

Export control — This document as well as the item(s) described herein may be subject to export control regulations. Export might require a prior authorization from competent authorities.

Translations — A non-English (translated) version of a document is for reference only. The English version shall prevail in case of any discrepancy between the translated and English versions.

18.4 Trademarks

Notice: All referenced brands, product names, service names and trademarks are the property of their respective owners.

19. Contact information

For more information, please visit: http://www.nxp.com

For sales office addresses, please send an email to: salesaddresses@nxp.com

11.1 12 12.1 13 14 15 15.1 15.2 15.3 15.4 16 17 18 18.1 18.2 18.3 18.4 19 20

Self-supplied high-speed CAN transceiver with Sleep mode

20. Contents

1	General description	. 1
2	Features and benefits	. 1
2.1	General	. 1
2.2	Designed for automotive applications	. 1
2.3	Integrated supply voltage for the CAN	
	transceiver (V _{BUF})	. 1
2.4	Power Management	. 2
2.5	System control and diagnostic features	. 2
3	Ordering information	
4	Block diagram	. 3
5	Pinning information	. 4
5.1	Pinning	
5.2	Pin description	
6	Functional description	. 5
6.1	System controller	. 5
6.1.1	Operating modes	
6.1.1.1	Normal mode	
6.1.1.2	Standby mode	. 6
6.1.1.3	Sleep mode	. 7
6.1.1.4	Off mode	. 7
6.1.1.5	Overtemp mode	. 7
6.1.1.6	Hardware characterization for the UJA1162	
	operating modes	
6.1.2	Mode control via pin SLPN	
6.2	Power supplies	
6.2.1	Battery supply voltage (V _{BAT})	
6.2.2	CAN supply voltage (V _{BUF})	
6.3	High-speed CAN transceiver	
6.3.1	CAN operating modes	
6.3.1.1	CAN Active mode	
6.3.1.2	CAN Offline and Offline Bias modes	
6.3.1.3	CAN off	10
6.3.2	CAN standard wake-up	
6.4	WAKE pin	11
6.5	VIO supply pin	11
6.6 6.7	CAN trail and fortunes	12
6.7.1	CAN fail-safe features	12
6.7.1		12 12
6.7.3	Pull-up on TXD pin	12
6.7.4	Loss of power at pin BAT	12
7	Limiting values	13
8	Thermal characteristics	14
9	Static characteristics	14
10	Dynamic characteristics	17
11	Application information	19

Application diagram	 19
Test information	 20
Quality information	 20
Package outline	 21
Handling information	 22
Soldering of SMD packages	 22
Introduction to soldering	 22
Wave and reflow soldering	22
Wave soldering	 22
Reflow soldering	 23
Soldering of HVSON packages	 24
Revision history	 25
Legal information	 26
Data sheet status	 26
Definitions	 26
Disclaimers	 26
Trademarks	 27
Contact information	 27
Contents	28

Please be aware that important notices concerning this document and the product(s) described herein, have been included in section 'Legal information'.

© NXP B.V. 2013.

All rights reserved.

For more information, please visit: http://www.nxp.com For sales office addresses, please send an email to: salesaddresses@nxp.com